Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/069,792	BUERCK ET AL.
Examiner	Art Unit
Ouveb H. Nauven	2614

SEARCHED				
Class	Subclass	Date	Examiner	
379	220.01 221.01	7/13/2006	QN	
370	395.2 395.21 352	7/13/06	QN	
above	updated	1/17/2007	QN	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOT (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
Searched: East, USPGPub, USPAT	7/13/06	QN
Inventor searched through PALLM database	7/13/06	QN
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